## Notice of References Cited Application/Control No. | Applicant(s)/Patent Under Reexamination NAKHJIRI ET AL. | Examiner | Art Unit | Page 1 of 1

## U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-2004/0029585	02-2004	Akgun et al.	455/432.2
*	ЪВ	US-6,963,550	11-2005	Choi et al.	370/331
*	С	US-2004/0063431	04-2004	Julka et al.	455/436
*	D .	US-2003/0212764	11-2003	Trossen et al.	709/219
*	E	US-6,725,042	04-2004	Park, Sang-Jo	455/436
*	F	US-7,110,377	09-2006	Hsu et al.	370/331
*	G	US-6,404,754	06-2002	Lim, Byung Keun	370/338
*	Н	US-6,671,265	12-2003	Hwang et al.	370/331
*	I	US-7,043,243	05-2006	Kobylinski et al.	455/437
*	J	US-6,163,694	12-2000	Lind et al.	455/435.3
	. K	US-			
	L	US-			
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N				·	
	0					
	Р					
	Q					
	R				·	
	s					
	Т					

## NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	x	·

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